

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	23	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 11:23
S2	752	257/10,11.ccls. 438/20.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 11:23
S3	1	S1 and S2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:05
S4	5	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode) and tension	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:06
S5	4	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode) and (thermal\$2 adj (expansion or expand or expanding))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:07
S6	2	"5710483".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/23 11:41
S7	23	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:05
S8	786	257/10,11.ccls. 438/20.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:05
S9	1	S7 and S8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:07

S10	0	S7 and S8 and @pd>"20041223"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:06
S11	0	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode) and @pd>"20041223"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:06
S12	0	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode) and tension and @pd>"20041223"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:07
S13	0	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode) and (thermal\$2 adj (expansion or expand or expanding)) and @pd>"20041223"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:07
S14	1	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode) and tensile	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 13:10
S15	832	257/10,11.ccls. 438/20.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 11:23
S16	1	(mesh adj grid) and (electron adj emission) and field and (gate adj electrode) and @pd>"20050426"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 13:01
S17	0	S15 and S16	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 11:24
S18	0	"kr 1020020078977 A"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 12:53
S19	0	"kr 20020078977 A"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 12:53

S20	1	"kr 2002078977 A"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 12:55
S21	1	cha.in. and cho.in. and han.in. and jung.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 12:56
S22	1	((field adj emission) and array and electron and gate and hole and (mesh adj grid) and (thermally or thermal) and tensile).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/14 13:02